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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/088,306	03/18/2002	Hiromoto Ohno	Q60716	2926	
23373 75	590 05/26/2006		EXAMINER		
SUGHRUE MION, PLLC			WARTALOWICZ, PAUL A		
2100 PENNSYLVANIA AVENUE, N.W. SUITE 800			ART UNIT	PAPER NUMBER	
WASHINGTO	WASHINGTON, DC 20037		1754		
			DATE MAILED: 05/26/2006		

Please find below and/or attached an Office communication concerning this application or proceeding.

				18/		
		Application No.	Applicant(s)			
Office Action Summary		10/088,306	OHNO ET AL.			
		Examiner	Art Unit			
		Paul A. Wartalowicz	1754			
 Period for	The MAILING DATE of this communication app Reply	ears on the cover sheet with the c	orrespondence address			
WHICH - Extens after S - If NO p - Failure Any re	PRTENED STATUTORY PERIOD FOR REPLY HEVER IS LONGER, FROM THE MAILING DATE ions of time may be available under the provisions of 37 CFR 1.13 (X (6) MONTHS from the mailing date of this communication. Deeriod for reply is specified above, the maximum statutory period we to reply within the set or extended period for reply will, by statute, ply received by the Office later than three months after the mailing of patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tin rill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	N. nely filed the mailing date of this communication (D) (35 U.S.C. § 133).			
Status						
1)⊠ [Responsive to communication(s) filed on 16 M	arch 2006	•			
·		action is non-final.	•			
· —	☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
	closed in accordance with the practice under E					
Dispositio	on of Claims		•			
4) 🖂 (Claim(s) <u>1-22</u> is/are pending in the application.					
, 4	a) Of the above claim(s) 23 3 sare withdraw	vn from consideration.				
	Claim(s) is/are allowed.					
6)⊠ (Claim(s) <u>1-22</u> is/are rejected.					
7) 🗌 (Claim(s) is/are objected to.					
8) 🗌 (Claim(s) are subject to restriction and/or	r election requirement.				
Application	on Papers					
9)□ T	The specification is objected to by the Examine	r.				
10)⊠ T	he drawing(s) filed on 18 March 2002 is/are: a	a)⊠ accepted or b)⊡ objected t	o by the Examiner.			
,	Applicant may not request that any objection to the	drawing(s) be held in abeyance. See	e 37 CFR 1.85(a).			
I	Replacement drawing sheet(s) including the correct	ion is required if the drawing(s) is ob	jected to. See 37 CFR 1.121(d).		
11) 🔲 T	he oath or declaration is objected to by the Ex	aminer. Note the attached Office	Action or form PTO-152.			
Priority u	nder 35 U.S.C. § 119					
a)[∑	Acknowledgment is made of a claim for foreign ☐ All b) ☐ Some * c) ☐ None of:)-(d) or (f).			
	1. Certified copies of the priority documents					
	2. Certified copies of the priority documents	• •				
•	 Copies of the certified copies of the prior application from the International Bureau 	•	ed in this National Stage			
* S	ee the attached detailed Office action for a list	, ,,,	- d			
O.		or are coramon copies not receive				
Attachment((s)					
1) Notice	of References Cited (PTO-892)	4) Interview Summary				
	of Draftsperson's Patent Drawing Review (PTO-948) ation Disclosure Statement(s) (PTO-1449 or PTO/SB/08)	Paper No(s)/Mail D	ate Patent Application (PTO-152)			
	No(s)/Mail Date	6) Other:	αιοπι προμοσιίοπ (π.10-132)			

DETAILED ACTION

Response to Arguments

Applicant's arguments filed on March 16, 2006 have been fully considered but they are not persuasive.

Applicant argues that CHF₃ was added to the test waste stream to confirm that NF₃ was selectively destroyed without converting CHF₃ and that the feed of example 3 containing 3 weight % CHF₃ is not an etching gas or a cleaning gas, but rather attempts to simulate a waste gas stream.

This argument is not persuasive for the following reason: Hsuing et al. teach a feedstock that is representative of a stream that has been used in the laboratory for semiconductor cleaning or etching (col. 4, lines 10-14) and CHF $_3$ is most reactive FC used in electronics (suggesting use in a semiconductor feed stream, col. 5, lines 56-60). The motivation stems from the reasoned explanation that CHF $_3$ and SF $_6$ are used in the semiconductor industry and for similar purposes (col. 4, lines 12-14) such that it would be obvious to use them in similar amounts and that the stream in example 3 is a simulation of a stream used in a semiconductor application; and it would be obvious to one of ordinary skill in the art to determine through routine experimentation the amount of SF $_6$ given the teachings of Hsuing et al.

Applicant argues that Hsuing et al. does not teach or describe a cleaning gas as a single unit operation.

This argument is not persuasive for the following reason: In response to applicant's argument that Hsuing et al. does not teach or describe a cleaning gas as a single unit operation, a recitation of the intended use of the claimed invention must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art. If the prior art structure is capable of performing the intended use, then it meets the claim.

Applicant argues that column 4, lines 12-13 describes that other FC's, such as CF_4 , C_2F_6 etc., are used in the semiconductor labs for similar purposes, and that this passage does not say that these other FC's are used in combination with NF_3 , but rather teaches to the contrary.

This argument is not persuasive for the following reason: The passage column 4, lines 12-13 is not relied upon to teach that other FC's are used in combination with NF₃, evidence for the other FC's used in combination with NF₃ is found in col. 3, lines 52-55 wherein Hsuing et al. describes a semiconductor exhaust stream comprising NF₃ with other FC's.

Applicant argues that the feed of example 1 describes treatment of a feed containing 1 % weight NF₃ and nitrogen and this has nothing to do with a cleaning gas, and also has nothing to do with an exhaust gas other than possibly suggesting that a typical exhaust gas might contain 1 % weight NF₃.

This argument is not persuasive for the following reason: Example 1 is not relied upon to teach the gas composition of Hsuing et al. Also, in response to applicant's argument that the feed of example 1 describes treatment of a feed containing 1 % weight NF₃ and nitrogen and this has nothing to do with a cleaning gas, a recitation of the intended use of the claimed invention must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art. If the prior art structure is capable of performing the intended use, then it meets the claim.

Applicant argues that there is no mention of NF_3 and that example 3 was a test to determine whether the most reactive of FC's would be converted in the reactor and not a test of etching rate or any other unit operation in a semiconductor fabrication, and thus there is no motivation or reason to consider substituting SF_6 for the CHF_3 and was not interested in the less reactive SF_6 .

This argument is not persuasive for the following reason: Hsuing et al. teach a feedstock that is representative of a stream that has been used in the laboratory for semiconductor cleaning or etching (col. 4, lines 10-14) and CHF₃ is most reactive FC used in electronics (suggesting use in a semiconductor feed stream, col. 5, lines 56-60). The motivation stems from the reasoned explanation that CHF₃ and SF₆ are used in the semiconductor industry and for similar purposes (col. 4, lines 12-14) such that it would be obvious to use them in similar amounts and that the stream in example 3 is a simulation of a stream used in a semiconductor application; and it would be obvious to

one of ordinary skill in the art to determine through routine experimentation the amount of SF_6 given the teachings of Hsuing et al.

Applicant argues that there is nothing to optimize in Hsuing et al. Regardless of the amount of FC's in the waste stream, the object of Hsuing et al. is to selectively destroy the NF₃ without converting FC's. The exhaust gas can contain as much or as little FC's as is produced by the various unit operations in the semiconductor facility.

This argument is not persuasive for the following reason: The disclosure wherein FC's are used in the semiconductor labs for etching comprise FC's and an inert gas as being the major constituent (col. 4, lines 12-16). As stated, usually the consumption of FC's in the semiconductor processes is not complete and therefore necessitates treatment of the exhaust gas (col. 4, lines 15-18). This is the motivation to optimize the amount of inert gas in the exhaust stream such that treatment of the exhaust stream does not be extensive. With the bulk of the exhaust stream being an inert gas, it is reasoned that the exhaust stream is diluted as much as possible without diminishing the utility of the FC stream in the applicability to the semiconductor industry.

Applicant argues that Hsuing et al. fail to describe a cleaning gas, because it concerns a waste gas.

This argument is not persuasive for the following reason: In response to applicant's argument that Hsuing et al. fail to describe a cleaning gas, because it

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concerns a waste gas, a recitation of the intended use of the claimed invention must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art. If the prior art structure is capable of performing the intended use, then it meets the claim.

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Applicant argues that there is nothing in Hsuing et al. that would suggest the desirability of modifying waste gas collected in a semiconductor fabrication facility to arrive at the claimed cleaning gas.

This argument is not persuasive for the following reason: Hsuing et al. teach a feedstock that is representative of a stream that has been used in the laboratory for semiconductor cleaning or etching (col. 4, lines 10-14) and CHF₃ is most reactive FC used in electronics (suggesting use in a semiconductor feed stream, col. 5, lines 56-60). The motivation stems from the reasoned explanation that CHF₃ and SF₆ are used in the semiconductor industry and for similar purposes (col. 4, lines 12-14) such that it would be obvious to use them in similar amounts and that the stream in example 3 is a simulation of a stream used in a semiconductor application; and it would be obvious to one of ordinary skill in the art to determine through routine experimentation the amount of SF₆ given the teachings of Hsuing et al.

Repeated Rejections

Claim Rejections - 35 USC § 103

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The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

- 1. Determining the scope and contents of the prior art.
- 2. Ascertaining the differences between the prior art and the claims at issue.
- 3. Resolving the level of ordinary skill in the pertinent art.
- 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.

Claims 1-22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hsuing et al. (U.S. 6106790).

Hsuing et al. teach a gas for cleaning (col. 4, lines 9-13) including NF₃, which may also have SF₆ and/or F₂ and also includes N₂, O₂, CF₄, C₂F₆ CHF₃ (col. 2, lines 61-66) with a 1% NF₃ concentration (col. 5, lines 21-22). Hsuing et al. fail to teach containing SF₆ in an amount of about 0.4-4.5 vol% and the inert gas is from 0.01 to 500 in terms of the volume ratio assuming SF₆ is 1.

Hsuing et al., however, teach the grouping of CHF_3 and SF_6 as fluorocarbons that can be used for similar purposes in the semiconductor lab (col. 4, lines 12-14). Hsuing et al. goes on to teach a feed comprising 3 wt% CHF_3 (col. 5, lines 55-56).

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Therefore, it would have been obvious to one of ordinary skill in the art at the time applicant's invention was made to have provided a 3 wt% SF₆ as both are used for similar purposes in semiconductor labs (col. 4, lines 12-14) as taught by Hsuing et al. It would have been obvious to one of ordinary skill in the art at the time the invention was made to optimize FC's such as CHF₃ and SF₆ since it has been held that discovering an optimum value or a result effective variable involved only routine skill in the art. In re Boesch, 617 F.2nd 272, 205 USPQ 215 (CCPA 1980). The artisan would have been motivated to optimize FC's such as CHF₃ and SF₆ by the reasoned explanation that if too much FC's are in the feed, the exhaust stream will need to be treated before venting into the atmosphere (col. 4, lines 15-19).

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Paul A. Wartalowicz whose telephone number is (571) 272-5957. The examiner can normally be reached on 8:30-6 M-Th and 8:30-5 on Alternate Fridays.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Stanley Silverman can be reached on (571) 272-1358. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Paul Wartalowicz May 17, 2006 COLLEEN P. COOKE